BF1100; BF1100R

Dual-gate MOS-FETs

Rev. 02 — 13 November 2007

Product data sheet

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FEATURES

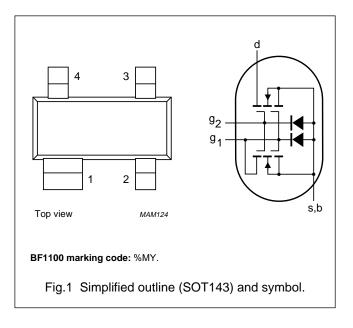
- Specially designed for use at 9 to 12 V supply voltage
- Short channel transistor with high forward transfer admittance to input capacitance ratio
- · Low noise gain controlled amplifier up to 1 GHz
- Superior cross-modulation performance during AGC.

APPLICATIONS

• VHF and UHF applications such as television tuners and professional communications equipment.

DESCRIPTION

Enhancement type field-effect transistor in a plastic microminiature SOT143 or SOT143R package. The transistor consists of an amplifier MOS-FET with source



QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{DS}	drain-source voltage		-	-	14	V
I _D	drain current		-	_	30	mA
P _{tot}	total power dissipation		-	-	200	mW
Tj	operating junction temperature		-	_	150	°C
y _{fs}	forward transfer admittance		24	28	33	mS
C _{ig1-s}	input capacitance at gate 1		-	2.2	2.6	pF
C _{rs}	reverse transfer capacitance	f = 1 MHz	-	25	35	fF
F	noise figure	f = 800 MHz	_	2	-	dB

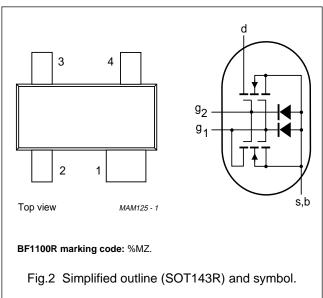
and substrate interconnected and an internal bias circuit to ensure good cross-modulation performance during AGC.

CAUTION

The device is supplied in an antistatic package. The gate-source input must be protected against static discharge during transport or handling.

PINNING

PIN SYMBOL		DESCRIPTION
1	s, b	source
2	d	drain
3	g ₂	gate 2
4	g 1	gate 1



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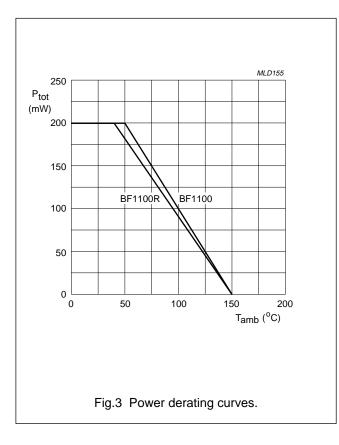
LIMITING VALUES

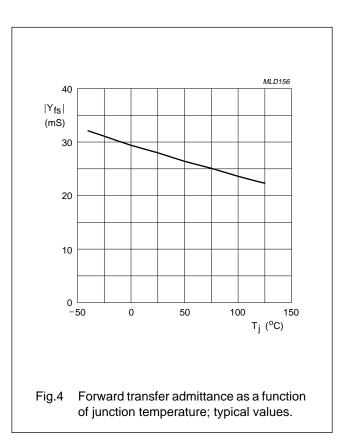
In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	14	V
ID	drain current		_	30	mA
I _{G1}	gate 1 current		_	±10	mA
I _{G2}	gate 2 current		-	±10	mA
P _{tot}	total power dissipation	see Fig.3			
	BF1100	up to T _{amb} = 50 °C; note 1	-	200	mW
	BF1100R	up to T _{amb} = 40 °C; note 1	_	200	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	operating junction temperature		_	+150	°C

Note

1. Device mounted on a printed-circuit board.





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THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient	note 1		
	BF1100		500	K/W
	BF1100R		550	K/W
R _{th j-s}	thermal resistance from junction to soldering point	note 2		
	BF1100	T _s = 92 °C	290	K/W
	BF1100R	T _s = 92 °C T _s = 78 °C	360	K/W

Notes

- 1. Device mounted on a printed-circuit board.
- 2. T_s is the temperature at the soldering point of the source lead.

STATIC CHARACTERISTICS

 $T_i = 25 \ ^{\circ}C$; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{(BR)G1-SS}	gate 1-source breakdown voltage	$V_{G2-S} = V_{DS} = 0; I_{G1-S} = 1 \text{ mA}$	13.2	20	V
V _{(BR)G2-SS}	gate 2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0; I_{G2-S} = 1 \text{ mA}$	13.2	20	V
V _{(F)S-G1}	forward source-gate 1 voltage	$V_{G2-S} = V_{DS} = 0; I_{S-G1} = 10 \text{ mA}$	0.5	1.5	V
V _{(F)S-G2}	forward source-gate 2 voltage	$V_{G1-S} = V_{DS} = 0; I_{S-G2} = 10 \text{ mA}$	0.5	1.5	V
V _{G1-S(th)}	gate 1-source threshold voltage	$V_{G2-S} = 4 V; V_{DS} = 9 V;$ $I_D = 20 \ \mu A$	0.3	1	V
		$V_{G2-S} = 4 V; V_{DS} = 12 V;$ $I_D = 20 \ \mu A$	0.3	1	V
V _{G2-S(th)}	gate 2-source threshold voltage	$V_{G1-S} = 4 V; V_{DS} = 9 V;$ $I_D = 20 \mu A$	0.3	1.2	V
		$V_{G1-S} = 4 V; V_{DS} = 12 V;$ $I_D = 20 \ \mu A$	0.3	1.2	V
I _{DSX}	drain-source current	$V_{G2-S} = 4$ V; $V_{DS} = 9$ V; R _{G1} = 180 kΩ; note 1	8	13	mA
		$V_{G2-S} = 4 \text{ V}; V_{DS} = 12 \text{ V};$ $R_{G1} = 250 \text{ k}\Omega; \text{ note } 2$	8	13	mA
I _{G1-SS}	gate 1 cut-off current	$V_{G2-S} = V_{DS} = 0; V_{G1-S} = 12 V$	_	50	nA
I _{G2-SS}	gate 2 cut-off current	$V_{G1-S} = V_{DS} = 0; V_{G2-S} = 12 V$	-	50	nA

Notes

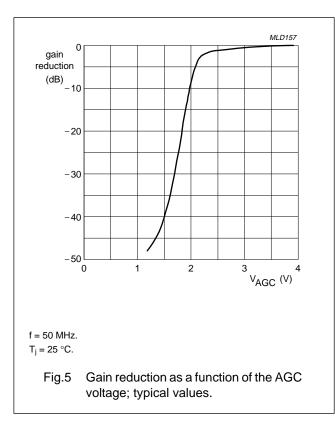
- 1. R_{G1} connects gate 1 to V_{GG} = 9 V; see Fig.27.
- 2. R_{G1} connects gate 1 to V_{GG} = 12 V; see Fig.27.

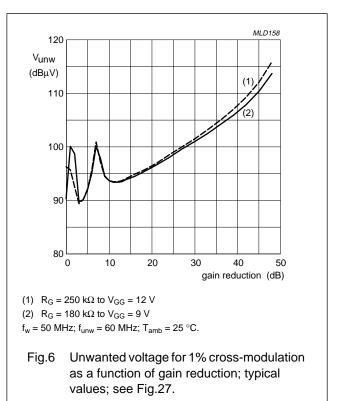
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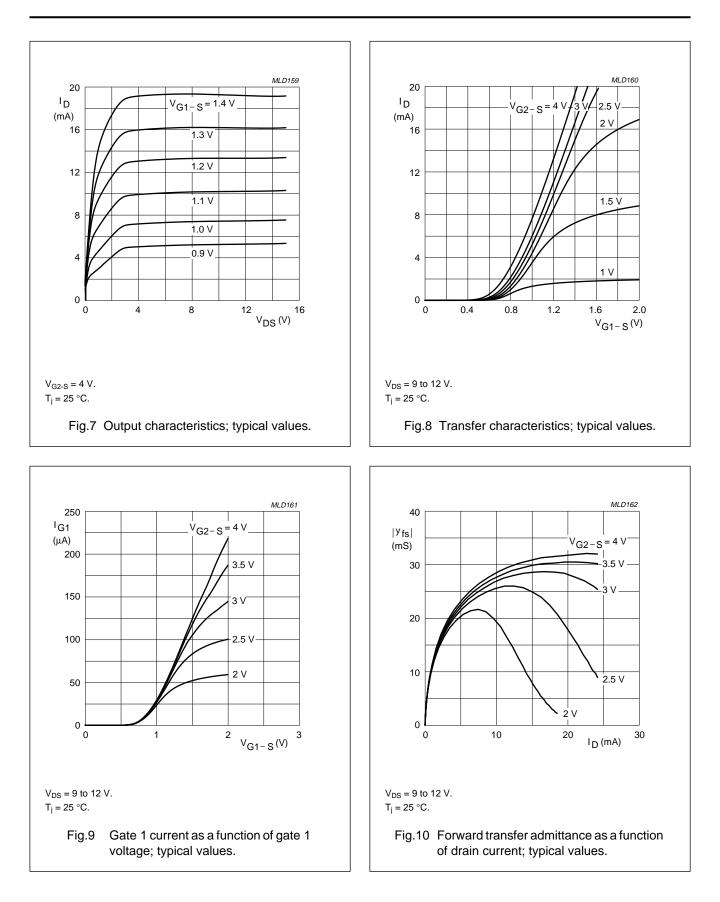
DYNAMIC CHARACTERISTICS

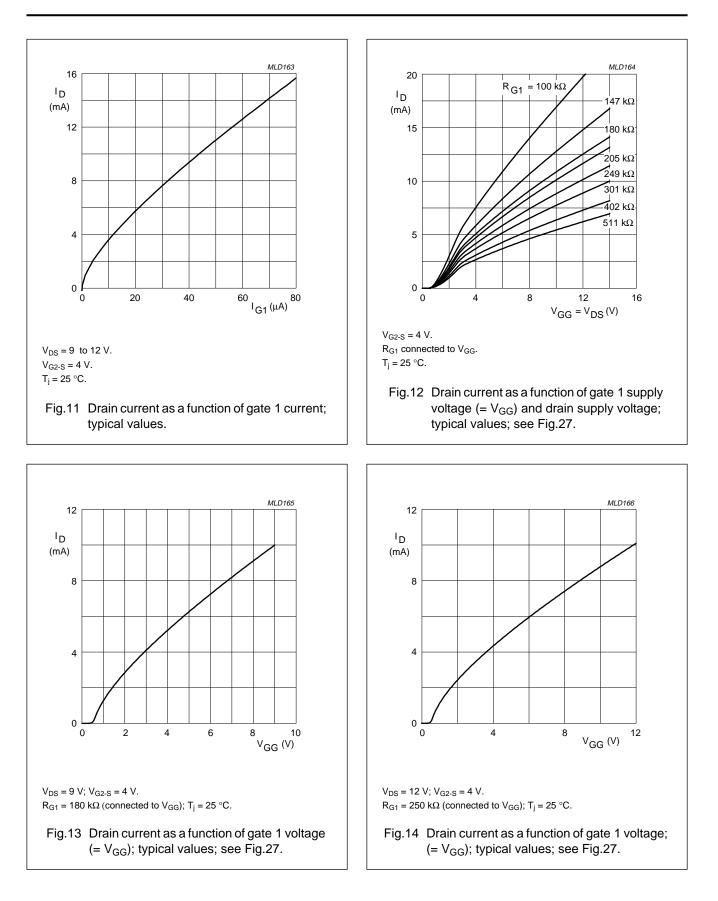
Common source; T_{amb} = 25 °C; V_{G2-S} = 4 V; I_D = 10 mA; unless otherwise specified.

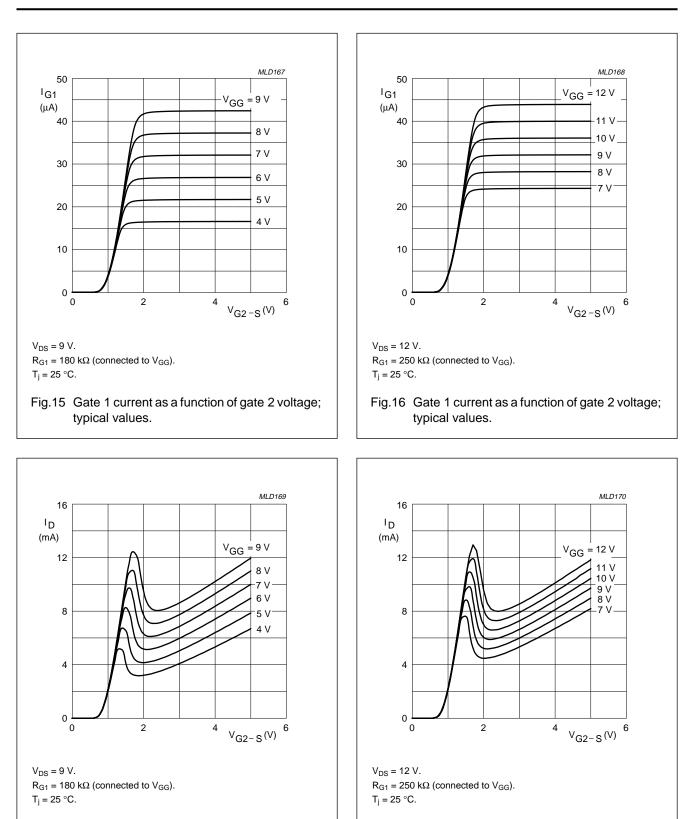
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
y _{fs}	forward transfer admittance	pulsed; T _j = 25 °C				
		$V_{DS} = 9 V$	24	28	33	mS
		V _{DS} = 12 V	24	28	33	mS
C _{ig1-s}	input capacitance at gate 1	f = 1 MHz				
		$V_{DS} = 9 V$	-	2.2	2.6	pF
		V _{DS} = 12 V	-	2.2	2.6	pF
C _{ig2-s}	input capacitance at gate 2	f = 1 MHz				
		$V_{DS} = 9 V$	_	1.6	-	pF
		V _{DS} = 12 V	-	1.4	-	pF
C _{os}	drain-source capacitance	f = 1 MHz				
		$V_{DS} = 9 V$	-	1.4	1.8	pF
		V _{DS} = 12 V	-	1.1	1.5	pF
C _{rs}	reverse transfer capacitance	f = 1 MHz				
		$V_{DS} = 9 V$	-	25	35	fF
		V _{DS} = 12 V	-	25	35	fF
F	noise figure	$f = 800 \text{ MHz}; G_S = G_{Sopt}; B_S = B_{Sopt}$				
		$V_{DS} = 9 V$	-	2	2.8	dB
		V _{DS} = 12 V	-	2	2.8	dB

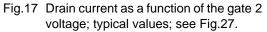


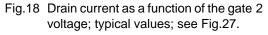


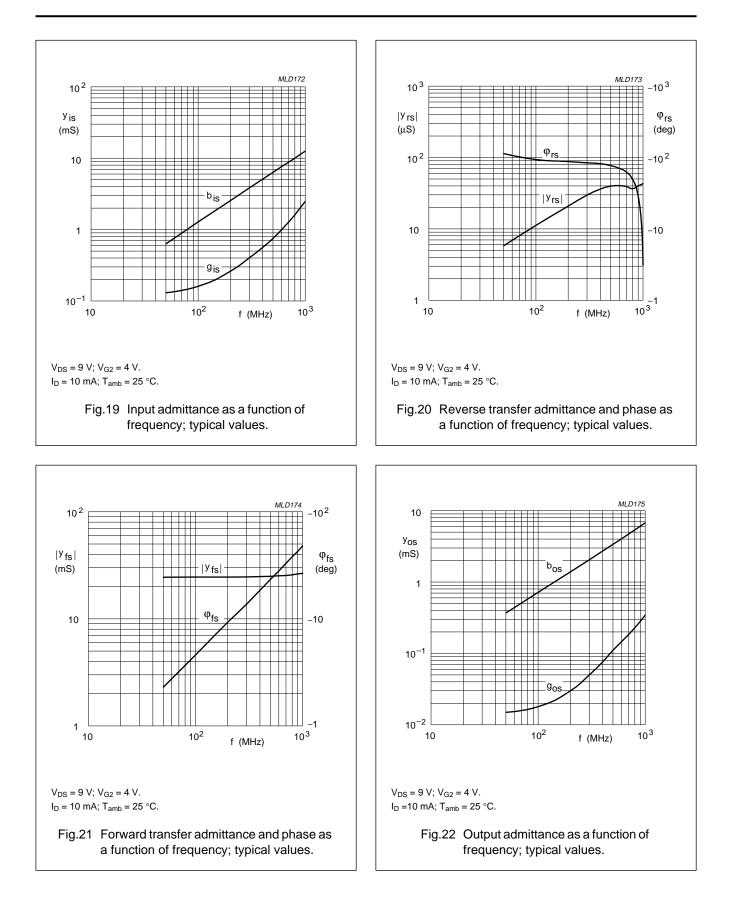


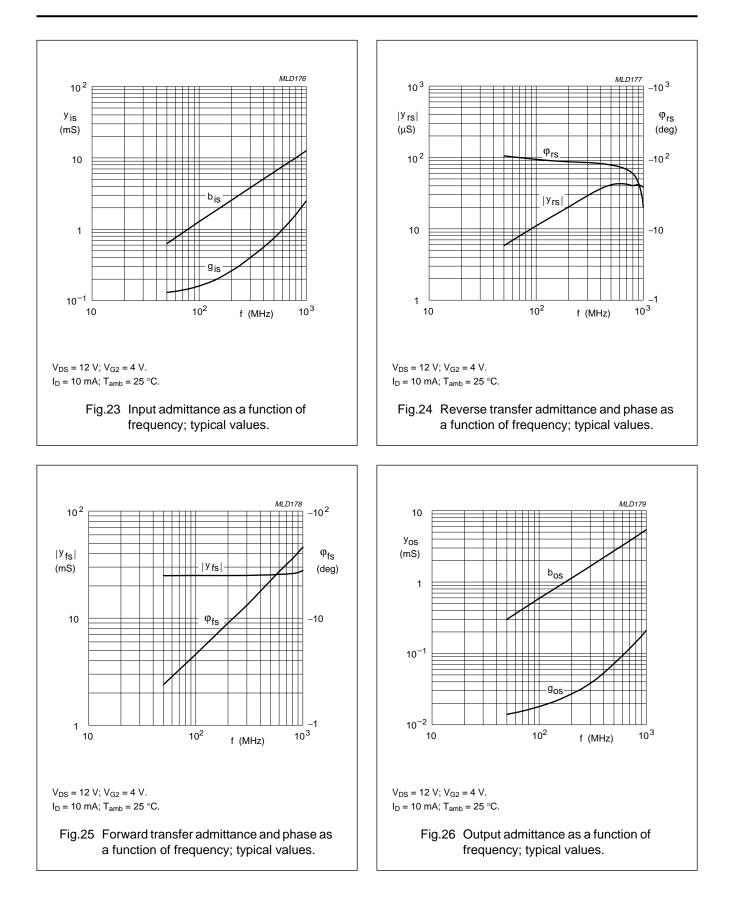


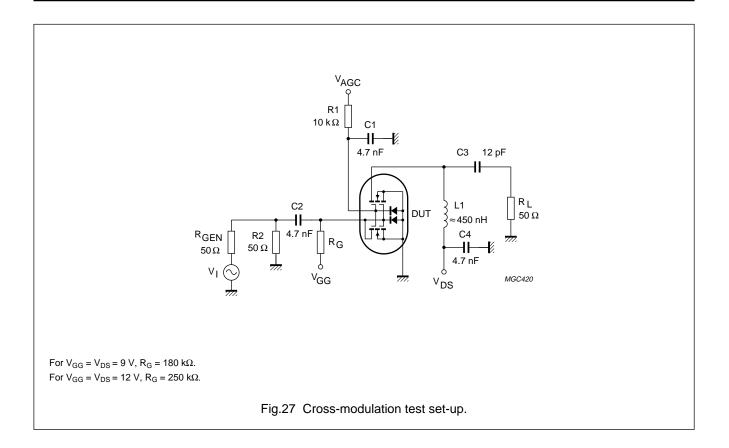












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f	S ₁₁ S ₂₁ S ₁₂		S ₁₁			S ₂₂		
(MHz)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)
50	0.986	-3.6	2.528	174.4	0.001	63.7	1.000	-2.0
100	0.983	-7.4	2.531	169.8	0.001	80.7	1.000	-4.2
200	0.974	-14.7	2.490	159.5	0.002	81.0	0.996	-8.1
300	0.960	-21.8	2.446	149.8	0.002	80.3	0.994	-11.9
400	0.953	-28.7	2.412	139.8	0.003	76.3	0.992	-15.7
500	0.933	-35.4	2.341	130.1	0.003	76.5	0.987	-19.4
600	0.915	-42.0	2.283	120.4	0.004	79.0	0.984	-23.0
700	0.895	-47.9	2.205	111.6	0.003	81.5	0.981	-26.7
800	0.880	-53.5	2.146	102.9	0.003	90.8	0.978	-30.3
900	0.864	-59.6	2.087	93.4	0.003	106.6	0.974	-33.9
1000	0.839	-65.0	1.998	84.4	0.003	135.4	0.971	-37.6

Table 1 Scattering parameters: V_{DS} = 9 V; V_{G2-S} = 4 V; I_D = 10 mA

Table 2 Noise data: V_{DS} = 9 V; V_{G2-S} = 4 V; I_D = 10 mA

f	F _{min}	Г	Γ _{opt}	
(MHz)	(dB)	(ratio)	(deg)	'n
800	2.00	0.67	43.9	0.89

Table 3 Scattering parameters: V_{DS} = 12 V; V_{G2-S} = 4 V; I_D = 10 mA

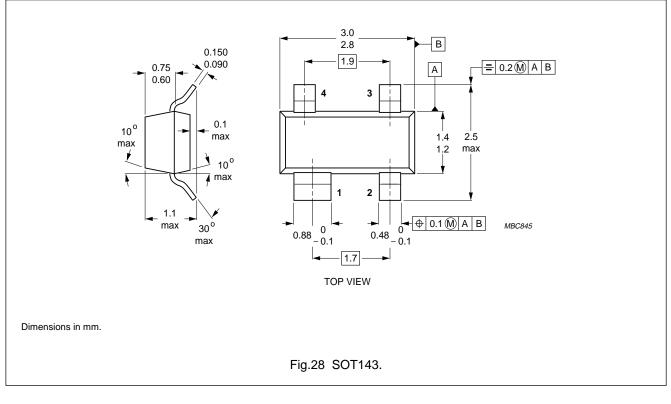
f	S ₁₁		S ₂₁ S ₁₂			\$ ₂₂		
(MHz)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)
50	0.986	-3.7	2.478	174.7	0.001	72.2	1.000	-1.6
100	0.984	-7.4	2.480	170.3	0.001	80.9	1.000	-3.5
200	0.974	-14.6	2.440	160.6	0.002	82.7	0.997	-6.6
300	0.960	-21.8	2.400	151.4	0.002	79.9	0.996	-9.7
400	0.953	-28.7	2.371	141.9	0.003	77.7	0.994	-12.8
500	0.933	-35.3	2.306	132.7	0.003	77.1	0.991	-15.8
600	0.915	-41.9	2.255	123.6	0.004	77.1	0.989	-18.7
700	0.894	-47.8	2.183	115.3	0.004	79.3	0.986	-21.7
800	0.879	-53.5	2.131	107.2	0.003	83.9	0.984	-24.6
900	0.863	-59.5	2.080	98.2	0.003	95.1	0.982	-27.5
1000	0.838	-65.0	1.999	89.7	0.003	115.8	0.980	-30.4

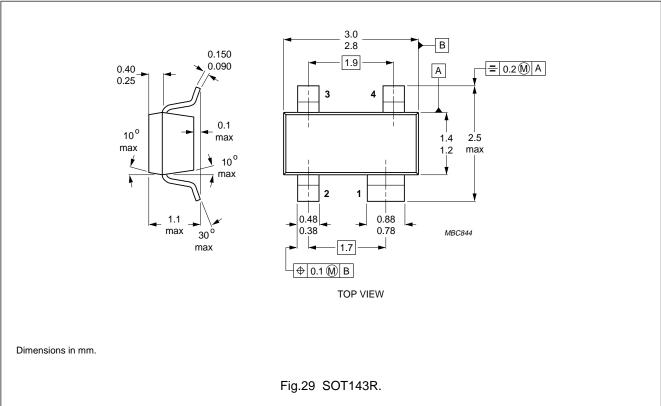
Table 4 Noise data: V_{DS} = 12 V; V_{G2-S} = 4 V; I_D = 10 mA

f	F _{min}		opt	-
(MHz)	(dB)	(ratio)	(deg)	'n
800	2.00	0.66	43.3	0.97

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PACKAGE OUTLINES





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Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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Revision history

Revision history							
Document ID	Release date	Data sheet status	Change notice	Supersedes			
BF1100_N_2	20071113	Product data sheet	-	BF1100_1			
Modifications: • Fig. 1 and 2 on page 2; Figure note changed							
BF1100_1	19950425	Product specification	-	-			

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